

<b>Notice of References Cited</b>	Application/Control No. <b>09/421,275</b>	Applicant(s)/Patent Under Reexam <b>Watanuki et al</b>	
	Examiner <b>Prenell Jones</b>	Art Unit <b>2667</b>	Page 1 of 1

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B	5,724,345	3/1998	Guarneri et al	370	316
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#### NON-PATENT DOCUMENTS

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